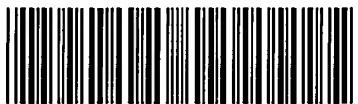


Search Notes**Application/Control No.**

10/634,229

Examiner

Sun J. Lin

Applicant(s)/Patent under Reexamination

BANSAL, JAI P.

Art Unit

2825

SEARCHED

Class	Subclass	Date	Examiner
716	1	2/11/2005	JSL
716	7	2/11/2005	JSL
716	8	2/11/2005	JSL
716	9	2/11/2005	JSL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST [USPAT;US- PGPUB;UPO;JPO;DERWENT;IBM_T DB]	2/11/2005	JSL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

